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| <b>Search Notes</b><br><br> | <b>Application/Control No.</b><br><br>10645402 | <b>Applicant(s)/Patent Under Reexamination</b><br><br>ALONE ET AL. |
|  | <b>Examiner</b><br><br>David Q Nguyen          | <b>Art Unit</b><br><br>2617  |

| SEARCHED |          |          |          |
|----------|----------|----------|----------|
| Class    | Subclass | Date     | Examiner |
| 455      | 426.1    | 08/18/08 | DN       |
| 455      | 41.2     | 08/18/08 | DN       |
| 455      | 433      | 08/18/08 | DN       |
| 455      | 432.1    | 08/18/08 | DN       |
| 370      | 329      | 08/18/08 | DN       |

| SEARCH NOTES  |          |          |
|---------------|----------|----------|
| Search Notes  | Date     | Examiner |
| Update search | 08/18/08 | DN       |

| INTERFERENCE SEARCH |          |      |          |
|---------------------|----------|------|----------|
| Class               | Subclass | Date | Examiner |
|                     |          |      |          |